捷多邦,专业PCB打样**SN54种O可373**出**SN74HCT373** OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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- Inputs Are TTL-Voltage Compatible
- Eight High-Current Latches in a Single Package
- High-Current 3-State True Outputs Can Drive up to 15 LSTTL Loads
- Full Parallel Access for Loading
- Package Options Include Plastic Small-Outline (DW) and Ceramic Flat (W)
 Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J)
 300-mil DIPs

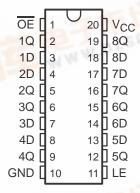
description

These 8-bit latches feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

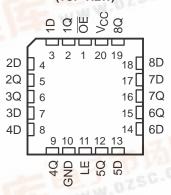
The eight latches of the 'HCT373 are transparent D-type latches. While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the levels that were set up at the D inputs.

An output-enable (\overline{OE}) input places the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

SN54HCT373 ... J OR W PACKAGE SN74HCT373 ... DW OR N PACKAGE (TOP VIEW)



SN54HCT373 . . . FK PACKAGE (TOP VIEW)



OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are off.

The SN54HCT373 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HCT373 is characterized for operation from –40°C to 85°C.



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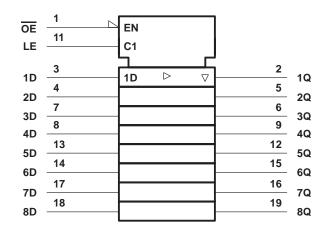


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FUNCTION TABLE (each latch)

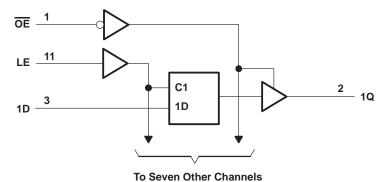
	INPUTS		OUTPUT
OE	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q ₀
Н	Χ	Χ	Z

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±35 mA
Continuous current through V _{CC} or GND	±70 mA
Package thermal impedance, θ _{JA} (see Note 2): DW package	97°C/W
N package	67°C/W
Storage temperature range, T _{stg}	. −65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

			SN	SN54HCT373			SN74HCT373			
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vсс	Supply voltage		4.5	5	5.5	4.5	5	5.5	V	
VIH	High-level input voltage	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	2			2			V	
VIL	Low-level input voltage	V _{CC} = 4.5 V to 5.5 V	0		0.8	0		0.8	V	
٧ _I	Input voltage		0		VCC	0		VCC	V	
Vo	Output voltage		0		VCC	0		VCC	V	
t _t	Input transition (rise and fall) time		0		500	0		500	ns	
T _A	Operating free-air temperature		-55		125	-40		85	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V	T _A = 25°C			SN54HCT373		SN74HCT373		UNIT
PARAMETER			VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
Vou	VI = VIH or VIL	I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		V
VOH	AI = AIH OL AIL	I _{OH} = -6 mA	4.5 V	3.98	4.3		3.7		3.84		V
Val	$V_I = V_{IH}$ or V_{IL}	I _{OL} = 20 μA	4.5 V		0.001	0.1		0.1		0.1	V
VOL		$I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	V
lį	$V_I = V_{CC}$ or 0		5.5 V		±0.1	±100		±1000		±1000	nA
loz	VO = VCC or 0		5.5 V		±0.01	±0.5		±10		±5	μΑ
Icc	$V_I = V_{CC}$ or 0,	IO = 0	5.5 V			8		160		80	μΑ
ΔI _{CC} ‡	One input at 0.5 V one of the of the order inputs at 0 or		5.5 V		1.4	2.4		3		2.9	mA
C _i			4.5 V to 5.5 V		3	10		10		10	pF

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.



^{2.} The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

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timing requirements over recommended operating free-air temperature range (unless otherwise noted)

		Vaa	T _A = 25°C		SN54HCT373		SN74HCT373		UNIT
		VCC	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
t _W	Pulse duration, LE high	4.5 V	20		30		25		
		5.5 V	17		27		23		ns
Γ.	Setup time, data before LE \downarrow	4.5 V	10		15		13		20
t _{su}		5.5 V	9		14		12		ns
t _h	Hold time, data after LE↓	4.5 V	10		10		10		no
		5.5 V	10		10		10		ns

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	TA	λ = 25°C	;	SN54H	CT373	SN74H0	CT373	UNIT
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
	D	Q	4.5 V		25	35		53		44	
. .	D	ď	5.5 V		21	32		48		40	20
^t pd	LE	Any O	4.5 V		28	35		53		44	ns
	LC	Any Q	5.5 V		25	32		48		40	
4	. =	Any Q	4.5 V		26	35		53		44	no
^t en	ŌĒ		5.5 V		23	32		48		40	ns
4	ŌĒ	Any O	4.5 V		23	35		53		44	no
^t dis	OE OE	Any Q	5.5 V		22	32		48		40	ns
4.		Any Q	4.5 V		10	12		18		15	no
t _t			5.5 V		9	11		16		14	ns

switching characteristics over recommended operating free-air temperature range, $C_L = 150 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	T,	λ = 25°C	;	SN54H	CT373	SN74H	CT373	UNIT
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	D	Q	4.5 V		32	52		79		65	
	D	Q	5.5 V		27	47		71		59	nc
гра	^t pd LE	Any Q	4.5 V		38	52		79		65	ns
			5.5 V		36	47		71		59	
	ŌĒ	Any O	4.5 V		33	52		79		65	20
^t en	OE	Any Q	5.5 V		28	47		71		59	ns
+.		Any Q	4.5 V		18	42		63		53	
t _t			5.5 V		16	38		57		48	ns

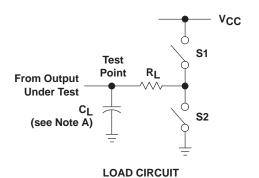
operating characteristics, $T_A = 25^{\circ}C$

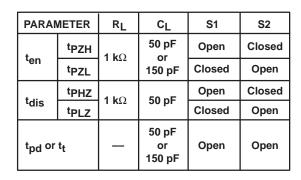
	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance per latch	No load	50	pF

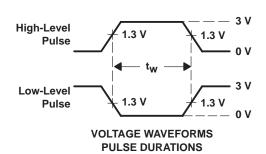


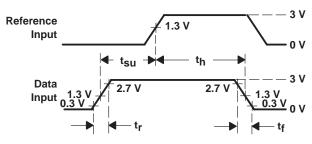
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PARAMETER MEASUREMENT INFORMATION

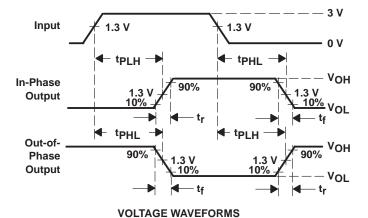


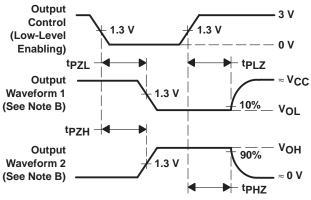






VOLTAGE WAVEFORMS
SETUP AND HOLD AND INPUT RISE AND FALL TIMES





VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS

NOTES: A. C_I includes probe and test-fixture capacitance.

PROPAGATION DELAY AND OUTPUT RISE AND FALL TIMES

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f = 6$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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